## Notice of References Cited Application/Control No. 10/014,108 Examiner Bradford F. Fritz Applicant(s)/Patent Under Reexamination IGARASHI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,832,511	11-1998	Beck et al.	707/201
*	В	US-3,955,073	05-1976	Carew et al.	702/161
*	C	US-5,970,217	10-1999	Nakamura, Fumihiko	358/1.14
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	7	US-			
	К	US-			
	الدا	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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